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Integration of Multivariate Loss Function Approach in the Hotelling's Charts under Banerjee and Rahim (1988) Weibull Shock Models

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Abstract

A proper monitoring of stochastic systems is the control charts of statistical process control and drift in characteristics of output may be due to one or several assignable causes. Although many research works have been done on the economic design of control charts with single assignable cause, the economic statistical design of T^2 control chart under Weibull shock model with multiple assignable causes and considering multivariate Taguchi loss function has not been presented yet. Using Taguchi loss function in the concept of quality control charts with economic and economic statistical design leads to better decisions in the industry. Based on the optimization of the average cost per unit of time and taking into account the different combination values of Weibull distribution parameters, optimal design values of sample size, sampling interval and control limit coefficient were derived and calculated. Then the cost models under non-uniform and uniform sampling scheme were compared. The results revealed that the model under multiple assignable causes with Taguchi loss function has a lower cost than single assignable cause model and integrated model with non-uniform sampling has a lower cost than that with uniform sampling.

Keywords: economic statistical design, T^2 control chart, multiple assignable causes, Weibull shock model, Taguchi loss function.

1. Introduction

The control charts technique for monitoring the process behavior is one of the basic tools of statistical process control (SPC). These charts are to distinguish between non-random and random variation where non-random variations cause a process to go out of control. Designing a control chart means to find the optimal values for three design parameters, namely, sample size, sampling interval and control limit coefficient which is done under three types of statistical, economic, and economic statistical designs. In the statistical designs, only statistical criteria are considered and in the economic designs, only the cost is important. A better alternative may be the economic statistical designs provided by Saniga (1989) in which both statistical and economic criteria are considered.

Most of the research works, like Duncan (1956) as the pioneer and then followers presented an

economic design of \overline{X} control charts with only one assignable cause. However, Duncan (1971), Gibra (1981), Tagaras and Lee (1988), Chung (1991), Chen and Yang (2002), Yang, Su, and Pearn (2010), Ahmed, Sultana, Paul, and Azeem (2014) presented an economic design of \overline{X} control charts with multiple assignable causes.

Economic and economic statistical design needs a probability distribution for the process failure mechanism (PFM). In most of the first research works, Exponential distribution that has a fixed failure rate were used Duncan (1956). Then other distributions such as Weibull, Gamma, Pareto, Generalized exponential, Burr 12 and...., is used as a failure mechanism Banerjee and Rahim (1988); Al-Oraini and Rahim (2002); Kraleti and Kambagowni (2010); Moghadam, Moghadam, Rafie, and Naderi (2016); Heydari, Moghadam, and Eskandari (2016). Banerjee and Rahim (1988) Extended Duncan (1956) by using the more flexible Weibull distribution for single assignable cause model and non-uniform sampling interval by considering the fact that using uniform sampling interval is not logical for the process with increasing failure rate. Then, Chen and Yang (2002) extended the model of Banerjee and Rahim (1988) from a single assignable cause to multiple assignable causes. In their paper, they showed that if the process were affected by several assignable causes, the cost of the model would be reduced in comparison with the model that wrongly assumed only single assignable cause.

With the complexity of products, the need for simultaneous monitoring of multiple quality characteristics appeared and caused the first economic design of the Hotelling T^2 control charts developed by Montgomery and Klatt (1972). In most of the research works such as Heikes, Montgomery, and Yeung (1974), Yang and Rahim (2006), Chen, Hsieh, and Chang (2007), Seif, Moghadam, Faraz, and Heuchenne (2011), Bahiraee and Raissi (2014), Faraz, Heuchenne, Saniga, and Costa (2014)the economic design of T^2 control chart is presented with single assignable cause Jolayemi and Berrettoni (1989) generalized Duncan (1971) cost model, and produce economic design of T^2 control chart with multiple assignable causes.

Due to interactions that parameter variations have on each other, using the concept of loss function for estimating costs of the low-quality product became important. Deming (1982) believed that Taguchi loss function Taguchi, Elsayed, and Hsiang (1989) describe the real world better where the minimum loss is in nominal value and any deviation from the nominal value will increase the amount of loss. Until now, a lot of economic and economic-statistical design developed for control chart by the combination of classic models like Duncan and Lorenzen Vance model by Taguchi loss function Safaei, Kazemzadeh, and Niaki (2012); Al-Ghazi, Al-Shareef, Usher, and Duffuaa (2007); Yang (1998). In economic and economic statistical design, loss cost under control and out of control is calculated with Taguchi loss function in many research works (Serel and Moskowitz (2008); Elsayed and Chen (1994)). In the case of multiple characteristics, Kapur and Cho (1996) developed a multivariate loss function for the multivariate quality characteristics. Chou, Chen, and Liu (2001) used the Taguchi loss function to develop ideas of Montgomery and Klatt (1972) for monitoring multivariate control charts to monitor mean and variance of the process jointly.

The economic statistical design of T^2 control charts under Weibull shock model with multiple assignable causes and multivariate Taguchi loss function are not performed yet, thus we present the economic statistical design of T^2 control chart with multiple assignable causes under Weibull shock model by considering multivariate Taguchi loss function. The use of the loss function in estimating the costs of producing non-conforming products in the production process makes the cost model more flexible. The loss functions that have been used in this field are univariate, so combining the Multivariate loss function with the cost model in the design of the economic-statistical T^2 control chart under Weibull Shock Models, is theoretically an innovation in the literature. Here, based on the Duncan (1971) with multiple assignable causes, sampling design of Banerjee and Rahim (1988) and cost structure of Chen and Yang (2002), an upgraded model is constructed. In our paper, by considering fixed sampling interval (uniform sampling scheme), we calculate the average cost for the cycle and compare our findings with the average cost in the case of non-uniform sampling. To calculate cost functions for uniform and non-uniform sampling schemes, we presented and proved the formulas of

AATS based on multiple assignable causes and ANF in the case of uniform and non-uniform sampling schemes . To construct economic statistical design we used penalty formula and both the statistical properties and optimization of loss cost have been considered simultaneously. The application of this function is more prominent in the industries where the products are economically or qualitatively more important and over estimation or under estimation of the target's value creates various losses.

The structure of this paper is as follows. In the second part, review of T^2 control chart is given. In the third part, some performance indicators are defined. Cost model offered with multiple special causes by considering uniform and non-uniform sampling scheme in section four. Improvement of cost model by the use of multivariate Taguchi loss function also presented in section 4. Section 5 includes economic statistical design. Section 6 shows that how to determine input parameters and optimizing cost model based on these input parameters and the comparison between cost models under multiple assignable causes and single assignable cause. The comparison between cost model under multiple assignable causes with uniform and non-uniform schemes also presented in section 6. Finally, the conclusion is presented in section 8.

Papers	Assignable Cause	PFM	DesignType	Type of control chart	Objective	Integrated with taguchi loss function
Duncan (1956)	Single	Exponential	Economic	X	Cost	No
Duncan (1971)	Multiple	Exponential	Economic	\overline{X}	Cost	No
Montgomery and Klatt (1972)	Single	Exponential	Economic	T^2	Cost	No
Lorenzen and Vance (1986)	Single	Exponential	Economic	\overline{X}	Cost	No
Banerjee and Rahim (1988)	Single	Weibull	Economic	\overline{X}	Cost	No
Jolayemi and Berrettoni (1989)	Multiple	Exponential	Economic	T^2	Cost	No
Rahim and Banerjee (1993)	Single	Increasing hazard rate distribution	Economic	\overline{X}	Cost	No
Elsayed and Chen (1994)	Single	Exponential	Economic	\overline{X}	Cost	Yes
Alexander, Dillman, Usher, and Damodaran (1995)	Single	Exponential	Economic	\overline{X}	Cost	Yes
Zhang and Berardi (1997)	Single	Weibull	Economic-Statistical	\overline{X}	Cost and α and $1 - \beta$	No
Chen and Yang (2002)	Multiple	Weibull	Economic	\overline{X}	Cost	No
Chou et al. (2001)	Single	Exponential	Economic	\overline{X}	Cost and α and $1 - \beta$	Yes
Ben-Daya and Duffuaa (2003)	Single	Exponential	Economic	\overline{X}	Cost	Yes
Al-Oraini and Rahim (2002)	Single	Gamma	Economic-Statistical	\overline{X}	Cost and α and $1 - \beta$	No
Yang and Rahim (2006)	Single	Weibull	Economic-Statistical	T^2	Cost and α and $1 - \beta$	No
Yu and Chen (2009)	Multiple	Exponential	Economic-Statistical	\overline{X}	Cost and α and $1 - \beta$	Yes
Kraleti and Kambagowni (2010)	Single	Pareto	Economic	\overline{X}	Cost	No
Yu, Tsou, Huang, and Wu (2010)	Multiple	Exponential	Economic-Statistical	\overline{X}	Cost and α and $1 - \beta$	No
Safaei et al. (2012)	Single	Exponential	Multiple Objective ESD	\overline{X}	Cost and α and $1 - \beta$	Yes
Heydari et al. (2016)	Single	Burr Xll	Economic- Statistical	\overline{X}	Cost and α and $1 - \beta$	No
Moghadam et al. (2016)	Single	Generalized Exponential	Economic	\overline{X}	Cost	No
This paper	Multiple	Weibull	Economic- statistical	T^2	Cost AATS and ANE	Ves

Table 1: Summarized literature review

2. T^2 control chart overview

Assume that the output of manufacturing process has p correlated quality characteristics and X has a p-variate normal distribution with known covariance matrix Σ and mean vector μ (when the process is under control, $\mu = \mu_0$). As an expansion of the univariate, Hotelling in 1931 presented the following statistic which, known as T^2 Hotelling:

$$T^{2} = (\overline{\mathbf{X}} - \boldsymbol{\mu}_{0})' \boldsymbol{\Sigma}^{-1} (\overline{\mathbf{X}} - \boldsymbol{\mu}_{0})$$
(1)

where $\overline{\mathbf{X}} = \frac{1}{n} \sum_{i=1}^{n} \mathbf{X}$ is sample mean vector. Assuming that the mean vector and covariance matrix is known, T^2 statistic has Chi-Square distribution with p degrees of freedom. Each of the T^2 values is compared with the upper α percentage of the Chi-Square distribution $(L = \chi_{\alpha}^2(p))$ and if the sample values fall below the control limit L, the process is considered in control, otherwise, the process is said to be out of control and the corresponding subgroup(s) is investigated. The occurrence of assignable causes shifts the mean process. In multivariate case, this change is calculated as follows:

$$d_i^2 = (\mu_i - \mu_0)' \Sigma^{-1} (\mu_i - \mu_0), \ i = 1, 2, \dots, s$$
 (2)

In fact, the above equation is Mahalanobis distance between μ_0 and μ_i vector where μ_i is p dimensional vector of process mean in the out of control situation due to the i^{th} assignable cause. In T^2 control chart, the probability of Type I error is calculated as follows:

$$\alpha = P(T^2 > \chi_{\alpha,p}^2 | \boldsymbol{\mu} = \boldsymbol{\mu}_0) \tag{3}$$

$$= \frac{1}{2^{\frac{P}{2}}\Gamma(\frac{P}{2})} \int_{L}^{\infty} x^{\frac{P}{2}-1} exp(-\frac{x}{2}) dx \tag{4}$$

(5)

where the i^{th} assignable cause occurs, the process mean shifts. The probability of detecting change in process mean is $1 - \beta_i$.

By considering $\beta_i = P(T^2 < \chi^2_{\alpha,p} | \boldsymbol{\mu} = \boldsymbol{\mu}_i), i = 1, 2, ..., s$ as the probability of error Type II, the above probability formula is:

$$\beta_i = exp\left(-\frac{\eta_i}{2} \sum_{j=0}^{\infty} \frac{\eta_i^j}{j! 2^{2j} \Gamma(j + \frac{P}{2})}\right)$$
 (6)

$$= \int_0^L x^{\frac{P}{2} + j - 1} exp(-\frac{x}{2}) dx \tag{7}$$

where $\eta_i = nd_i^2, i = 1, 2, ..., s$ is non-central parameter of χ^2 distribution.

3. Essential points

Following Banerjee and Rahim (1988), it is expected that the time of being under control until the occurrence of i^{th} assignable cause follows a Weibull distribution with probability density function and hazard rate as below:

$$f_i(t) = \lambda_i k t^{k-1} exp(-\lambda_i t^k). (t > 0, k \ge 1, \lambda_i > 0), i = 1, 2, ..., s.$$
 (8)

$$r_i(t) = \lambda_i k t^{k-1} \tag{9}$$

where k is shape parameter and λ_i is scale parameter. The process is investigated by taking samples of size n from X at time intervals h_1 , $h_1 + h_2$, $h_1 + h_2 + h_3$ and so on. Where h_j is defined as j^{th} sampling interval and we have $h_1 \geq h_2 \geq h_3$, ... (The proof of above inequality is given in Appendix B).

Sampling intervals are determined in a way that the probability of shift from a control state is fixed for all intervals when it is in control at the beginning of the interval. In other words, according to Banerjee and Rahim (1988), integrated hazard over each interval should be equal.

$$\int_{\omega_i}^{\omega_{j+1}} r_i(t) dt = \int_{\omega_0}^{h_1} r_i(t) dt, j = 1, 2, \dots$$
 (10)

Accordingly h_i (for more detail see Appendix C) obtained as follows

$$h_j = \left[j^{\frac{1}{k}} - (j-1)^{\frac{1}{k}} \right] h_1 \tag{11}$$

For sake of simplicity in deriving required equations, we define ω_i as below:

$$\omega_j = \Sigma_{i=1}^j h_i. \tag{12}$$

It is assumed that the process stops at the time of search and repair and the cost of sampling is negligible. To calculate the average cost per unit of time we need to define the following terms.

1. We define p_{ij} is the conditional probability that i^{th} assignable cause will occur during j^{th} sampling interval, given that i^{th} assignable cause not occur at time ω_{i-1} .

$$p_{ij} = \frac{\int_{\omega_{j-1}}^{\omega_j} f_i(t) \, dt}{\int_{\omega_{j-1}}^{\infty} f_i(t) \, dt} = 1 - exp(-\lambda_i(jh_1^k)).$$
 (13)

let $p_{ij} = p_i$, for (i = 1, 2, ..., S), (j = 1, 2, ...).

2. We define q_{ij} as the unconditional probability that i^{th} assignable cause will occur during the j^{th} sampling interval. Thus, we have:

$$q_{ij} = \int_{\omega_{j-1}}^{\omega_j} f_i(t), dt = e^{-\lambda_i \omega_{j-1}^k} - e^{-\lambda_i \omega_j^k} = (1 - p_i)^{j-1} p_i.$$
 (14)

3. Suppose that τ_{ij} be the expected duration of the in control period within sampling interval h_j , given that i^{th} assignable cause has occurred during this period. Thus, we have:

$$\tau_{ij} = E(T - \omega_{j-1} \mid \omega_{j-1} < T < \omega_j) \tag{15}$$

So the expected τ_i (the time that process be under control) during any sampling interval is as follows:

$$\tau_i = \sum_{j=1}^{\infty} \tau_{ij} q_{ij} = \sum_{j=1}^{\infty} \int_{\omega_{j-1}}^{\omega_j} (t - \omega_{j-1}) f_i(t) dt = \left(\frac{1}{\lambda_i}\right)^{\frac{1}{k}} \Gamma(1 + \frac{1}{k}) - h_1 p_i (1 - p_i) A(1 - p_i), \quad (16)$$

where for |x| < 1

$$A(X) = \sum_{j=0}^{\infty} (j+1)^{\frac{1}{k}} X^{j}.$$
 (17)

Let $AATS_i$ be the average time between occurrence shift in process mean owing to the i^{th} assignable cause and receiving a right alarm from control chart.

$$AATS_{i} = h_{1}p_{i}A(1-p_{i}) + \frac{\beta_{i}h_{1}p_{i}[p_{i}A(1-p_{i}) - (1-\beta_{i})A(\beta_{i})]}{1-p_{i}-\beta_{i}} - (\frac{1}{\lambda_{i}})^{\frac{1}{k}}\Gamma(1+\frac{1}{k}).$$
 (18)

The concept of $AATS_i$ is presented well in Figure 1. The proof of above formula is presented in Appendix D.

4. Cost model structure

4.1. Assumptions

In building our model for observing a process by a T^2 control chart we make the typical assumptions about the process as follows:

- 1. The p quality characteristics follow a multivariate normal distribution with mean vector μ and covariance matrix Σ .
- 2. The process is characterized by an in-control state, i.e. $\mu = \mu_0$.
- 3. The time interval that the process remains in control is a Weibull random variable expecting that the process starts in control state.
- 4. The occurrences of assignable causes are independent.

- 5. Multiple assignable causes produce "step changes" in the process mean from $\mu = \mu_0$ to a known $\mu = \mu_1$. This results in a known value of the Mahalanobis distance.
- 6. In this paper the shift occurred in process mean is noted by d_i . Three distributions of uniform, negative-exponential $\frac{1}{2}e^{-\frac{d_i}{2}}$ and half-normal $\frac{1}{\sqrt{2\pi}}e^{-\frac{(\frac{1}{2}d_i)^2}{2}}$ are considered as a prior for d_i . Considering these distributions as a prior would cover all values of d_i in a real industry.
- 7. "Drifting processes" are not a subject of this research. Assignable causes that affect process variability are not addressed; hence it is assumed that the covariance matrix Σ is constant over time.
- 8. Before the shift, the process is considered to be in a state of statistical control (in-control state).
- 9. The process is not self-correcting. That is, once a transition to an out-of-control state has occurred, the process can be returned to the in-control condition only by management intervention upon appropriate corrective actions.
- 10. The quality cycle starts with the in-control state and continues until the process is repaired after an out-of-control signal. It is assumed that quality cycle follows a Renewal Reward Process.
- 11. During the search for an assignable cause, the process is shut down.

4.2. Cost function in the case of non-uniform sampling

Every process begins at in control state. At that point, because of the occurrence of one assignable cause, the process will change to out of control state and after detection and repair; it goes back to the control state. This is called quality cycle that develops Renewal Reward Process where the average cost per unit time for cycle E(A) is obtained by the average cost per cycle E(C) divided by the average time per cycle E(T). We assumed that assignable causes affected the process. The occurrence time of any assignable cause follows Weibull distribution.

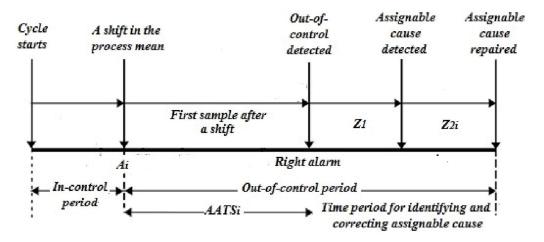


Figure 1: The quality cycle under control and out of control

Here it is assumed that after the occurrence of the i^{th} assignable cause, until the discovery of this deviation, the process will not disturb by other assignable causes. If the time until

occurrence of assignable causes noted by $T_1', T_2', ..., T_S'$, then the probability of being under control at time t is:

$$P(T' > t) = P(min(T_1', T_2', ..., T_S') > t) = exp^{-\lambda_0 t^k}$$
(19)

where $\lambda_0 = \sum \lambda_i$, $i = 1, 2, \dots, s$.

Therefore, the time of being in control until the occurrence of multiple assignable causes follows the Weibull distribution.

$$f_0(t) = \lambda_0 k t^{k-1} \exp(-\lambda_0 t^k). (t > 0, k \ge 1, \lambda_0 > 0).$$
(20)

We consider P_{0j} as the conditional probability that multiple assignable causes (i = 1, 2, ..., s) will occur during j^{th} sampling interval (j = 1, 2, ...) given that multiple assignable causes not occur at time ω_{j-1} . We obtain $p_{0j} = 1 - e^{-\lambda_0} h_1^k$. Here it is assumed $p_{0j} = p_0$.

The average time that the process is in control is:

$$\left(\frac{1}{\lambda_0}\right)^{\frac{1}{k}}\Gamma(1+\frac{1}{k}) + Z_0 A N F \tag{21}$$

In the above formula ANF is the average numbers of false alarm in the quality cycle and is equal to the production of average sample numbers before shift and probability of Type I error (α) .

If A is the event of the occurrence of single assignable cause, then average numbers of false alarm calculated as follows:

$$E(Number of sample sar et a ken before shift) = \sum_{j=0}^{\infty} j P(A \in (jh, (j+1)h))$$
 (22)

$$= \sum_{j=0}^{\infty} j(e^{-\lambda_0 j h_1^k} - e^{-\lambda_0 (j+1)h_1^k})$$
 (23)

$$= \frac{e^{-\lambda_0 h_1^k}}{1 - e^{-\lambda_0 h_1^k}}. (24)$$

Therefore, ANF is equal to:

$$ANF = \alpha \frac{1 - p_0}{p_0}. (25)$$

The average time of cycle is:

$$E(T) = (\frac{1}{\lambda_0})^{\frac{1}{k}} \Gamma(1 + \frac{1}{k}) + Z_0 ANF + AATS + Z_1 + \Sigma(\frac{\lambda_i}{\lambda_0}) Z_{2i}$$
 (26)

where

$$AATS = \sum_{i=1}^{s} \frac{\lambda_i}{\lambda_0} AATS_i. \tag{27}$$

For a better understanding of E(T) one can see Figure 1.

The average cost of cycle is:

$$E(C) = D_0(\frac{1}{\lambda_0})^{\frac{1}{k}}\Gamma(1 + \frac{1}{k}) + YANF + \sum_{i=1}^{s} \frac{\lambda_i}{\lambda_0} D_{1i}AATS_i + \sum_{i=1}^{s} \frac{\lambda_i}{\lambda_0} w_i$$
 (28)

$$+ (a+bn) \sum_{i=1}^{s} \frac{\lambda_i}{\lambda_0} (\frac{1}{1-\beta_i}) + (a+bn)Q.$$
 (29)

(30)

For better understanding of E(C) one can see Figure 1. The way of obtaining $\frac{\lambda_i}{\lambda_0}$ in above formula is presented in Appendix E.

In practice, each process starts from in control state. Then because of occurrence of one assignable cause, it goes to out of control state. It is clear that after repairing and fixing the assignable cause, the process returns to the initial state. This cycle is called quality cycle and its model follows the form of a Renewal Reward Process where the average cost per unit time for the cycle E(A) is calculated by the average cost per cycle E(C) divided by the average time per cycle E(T). In economic design, the purpose is optimizing E(A) without any constraint and finding optimal values for sampling interval, sample size and control limits coefficient.

4.3. Cost function in the case of uniform sampling

To evaluate the relative benefits of non-uniform sampling plan in comparison with uniform sampling plan under multiple assignable causes cost model, and by considering fixed sampling interval, we calculate average time and the average cost for the cycle and analyze them. If h is a fixed sampling interval, then we can obtain E(T) as follows:

$$E(T) = (\frac{1}{\lambda_0})^{\frac{1}{k}} \Gamma(1 + \frac{1}{k}) + Z_0 ANF + AATS + Z_1 + \Sigma(\frac{\lambda_i}{\lambda_0}) Z_{2i},$$
(31)

where

$$AATS = \sum_{i=1}^{s} \frac{\lambda_i}{\lambda_0} AATS_i \tag{32}$$

$$AATS_i = \frac{h}{1 - \beta_i} - \tau_i \tag{33}$$

$$\tau_i = (\frac{1}{\lambda_0})^{\frac{1}{k}} \Gamma(1 + \frac{1}{k}) - hQ_i \tag{34}$$

$$Q_i = \sum_{j=1}^{\infty} e^{\lambda_i (jh)^k} \tag{35}$$

$$ANF = \alpha Q, Q = \sum_{j=1}^{\infty} e^{\lambda_0 (jh)^k}$$
(36)

We also obtain E(C) as fallows:

$$E(C) = D_0(\frac{1}{\lambda_0})^{\frac{1}{k}}\Gamma(1 + \frac{1}{k}) + YANF + \sum_{i=1}^{s} \frac{\lambda_i}{\lambda_0} D_{1i}AATS_i + \sum_{i=1}^{s} \frac{\lambda_i}{\lambda_0} w_i$$
 (37)

$$+ (a+bn) \sum_{i=1}^{s} \frac{\lambda_i}{\lambda_0} (\frac{1}{1-\beta_i}) + (a+bn)Q.$$
 (38)

4.4. Improvement of cost function by using Taguchi loss function

To consider the intangible costs, Taguchi loss function is used. In this model, E(A) is used as an economic criterion to assess the measurable costs. To estimate D_0 and D_1 Taguchi loss function is used. Taguchi, Chowdhury, and Wu (2005) characterized product quality as the loss a product bestows to society from the time the product is delivered and presented the quality loss function as a quality measure. They showed that a quadratic loss function adequately represents economic loss due to the deviation of a quality characteristic from the target value. The Taguchi loss function is presented bellow:

$$L(Y) = C(X - t)^2 \tag{39}$$

In the above formula L(Y), is the loss connected with the value of quality characteristic X, the target value of the quality characteristic is denoted by t, and C is a constant value depending on the width of the specification and the cost at the specification limits.

Based on Eq. (31), Kapur and Cho (1996) improved a multivariate loss function for the multivariate quality characteristics $Y_1, Y_2, ..., Y_P$. The multivariate loss function presented below

$$L(Y_1, Y_2, ..., Y_P) = \sum_{i=1}^{P} \sum_{j=1}^{i} C_{ij} (Y_i - t_i) (Y_j - t_j)$$
(40)

where t_j is the target of the j^{th} characteristic, and C_{ij} is a constant depending on the cost at the specification limits and the width of the specification. Chen (1995) discussed completely about determining the values of C_{ij} . Specifically, if Y_i and Y_j are independent, then $C_{ij} = 0$. The expected loss per unit of product may be obtained by the use of expectation operator on both sides of Eq. (32).

$$E(L(Y_1, Y_2, ..., Y_P)) = \sum_{i=1}^{P} C_{ii}[(\mu_i - t_i) + \sigma_i^2] + \sum_{i=2}^{P} \sum_{j=1}^{i} C_{ij}[(\mu_i - t_i)(\mu_j - t_j) + \sigma_{ij}]$$
(41)

In the above formula μ_j and σ_j^2 are the mean and variance of Y_j , and the covariance of Y_j and the covariance of Y_i and Y_j is σ_{ij} .

If we consider Eq (33) when the process under control, $(\mu = \mu_0)$, L_{in} is obtained. Lout, i is obtained by considering Eq (33), when the process is out of control $\mu = \mu_1$. We improve Eq (23) and (30) by using PL_{in} instead of D_0 and PLout, i instead of D_{1i} . In this paper, we consider two quality characteristic. Let (Y_1, Y_2) be two quality characteristic, and assume that when the process is in-control:

$$(Y_1, Y_2) \sim BN(\vec{\mu_0} = (\mu_{Y_1}, \mu_{Y_2}), \Sigma_0), (T_1'', T_2'') = (\mu_{Y_1} - \delta_5 \sigma_1, \mu_{Y_2} - \delta_6 \sigma_2)$$
(42)

where $\sigma_{12} = \rho \sigma_1 \sigma_2$ is the covariance of (Y_1, Y_2) and ρ is the coefficient of correlation and $-1 \le \rho \le 1$. δ_5 and δ_6 are target shifts, in order to simplify the process we set $\delta_5, \delta_6 \ge 0$. When the process is out-of-control,

$$(Y_1, Y_2) \sim BN(\vec{\mu_1} = (\mu_{Y_1} + \delta_{1i}, \mu_{Y_2} + \delta_{2i}), \Sigma_0), (T_1'', T_2'') = (\mu_{Y_1} - \delta_5 \sigma_1, \mu_{Y_2} - \delta_6 \sigma_2)$$
(43)

where both δ_{1i} and δ_{2i} for i = 1, 2, ..., s are the mean partial shift and $\delta_{1i}, \delta_{2i} \neq 0$. We use the following bivariate loss function:

$$L(Y_1, Y_2) = K_{11}(Y_1 - T_1'')^2 + K_{12}(Y_1 - T_1'')(Y_2 - T_2'') + K_{22}(Y_2 - T_2'')^2$$
(44)

where (Y_1, Y_2) are quality characteristics, T_1 and T_2 are target values and K_{11}, K_{22} and K_{12} are constants.

$$E(L(Y_1, Y_2)) = K_{11}E[(Y_1 - T_1'')^2] + K_{12}E[(Y_1 - T_1'')(Y_2 - T_2'')] + K_{22}E[(Y_2 - T_2'')^2]$$
 (45)

 L_{in} is obtained by considering Eq (37) when the process is in control and $L_{out,i}$ is obtained by considering Eq (37).

5. Economic statistical design

In the statistical design of control charts, optimal performance of design parameters obtained in terms of statistical criteria. Economic design of control charts based on economic criteria.

In this paper, economic statistical design performed based on minimizing average cost per time and by considering maximum values for the average time between occurrence shift in process mean and receiving a right alarm from control chart (AATS) and average numbers of false alarm in the quality cycle (ANF). If we note the average cost of a cycle per time by E(A) and the set of economic design parameters of T^2 control charts by F, we can show economic statistical design of T^2 control charts as follows:

minimize $E_F(A)$

subject to $AATS \leq AATS_U$ and $ANF \leq ANF_U$

where $AATS_u$ and ANF_u are the corresponding bounds of values of AATS and ANF.

6. Illustrative example

To determine the optimal model parameters, the R package Optim is used through minimizing loss cost. Some of the parameters like cost parameters (Y, a, b) and time parameters (Z_0, Z_1) that are fixed have been determined based on past experience. In this model, ω_i and Z_{2i} are non-fixed cost and time parameters, respectively. Also, there are Weibull distribution parameters (λ_i, k) , shift parameter d_i and (n, h_1, L) parameters in the model. In the numerical example we assume:

$$Y = 500, a = 20, b = 4.22, Z_0 = 0.25, Z_1 = 0.25$$

The above parameters are not affected by the occurrence of different assignable causes and the shift created in the mean process. However, W_i, Z_{2i}, λ_i and parameters are assumed to be a function of d_i . We calculated above parameters below:

a) It is assumed (Y_1, Y_2) be two quality characteristic, and assume that when process is incontrol:

$$(Y_1, Y_2) \sim BN(\mu_0 = (2, 3), \Sigma_0)$$
 (46)

$$(T_1'', T_2'') = (0.32, 1.92)$$
 (47)

When covariance matrix is:

$$\begin{bmatrix} 4 & 1 \\ 1 & 9 \end{bmatrix}$$

We assume that process is disturbed by ten assignable causes which produce ten shift values in process mean vector. We also assume that when the process is going to out of control, the mean of the process is shifted and we have

$$\mu_i = (2 + \delta_{1i}, 3 + \delta_{2i}) \tag{48}$$

Values of δ_{1i} and δ_{2i} and d_i related to them, are listed in Table 2.

As seen before, L_{in} and $L_{out,i}$ is obtained by considering Eq(37) and we have $D_0 = PL_{in}$ and $D_{1i} = PL_{out,i}$. We assume $K_{11} = 1.6$, $K_{12} = 4$, $K_{22} = 5$, P = 17. Thus we obtain $D_0 = 946$,

$$D_{1i} = (948, 955.87, 956.624, 957.37, 958.12, 959, 960.02, 960.7, 961.5, 962.24)$$

b) Suppose that $d_i = 0.018$ is a base case. Yang and Rahim (2006) single assignable cause model is compared with our multiple assignable causes model. Base case parameters are also considered for single assignable cause model

$$W = 1100, D_1 = 958.12, Z_2 = 0.75, \lambda = 0.05, d = 0.018$$

 d_i A_i δ_{1i} δ_{2i} 1 0.02 0.03 0.036 2 0.0220.01 0.020.009 3 0.0190.0214 0.008 0.018 0.0195 0.007 0.017 0.018 6 0.0060.0140.0157 0.0050.0090.018 0.0040.0080.0089 0.003 0.0070.007 10 0.002 0.006 0.006

Table 2: Model partial shift and shift mean parameters

Table 3: Model input parameters

PD_i						Z_{2i}			W_{i}			λ_i			
$\overline{A_i}$	d_i	NE	Un	HN	D_{1i}	NE	Un	HN	NE	Un	HN	NE	Un	HN	
1	0.036	0.491	0.100	0.399	948	0.743	0.75	0.75	1090	1100	1100	0.0154	0.0156	0.0156	
2	0.022	0.495	0.100	0.399	955.9	0.749	0.75	0.75	1098	1100	1100	0.0155	0.0156	0.0156	
3	0.021	0.495	0.100	0.399	956.6	0.749	0.75	0.75	1098	1100	1100	0.0155	0.0156	0.0156	
4	0.019	0.495	0.100	0.399	957.4	0.750	0.75	0.75	1099	1100	1100	0.0155	0.0156	0.0156	
5	0.018	0.496	0.100	0.399	958.1	0.750	0.75	0.750	1100	1100	1100	0.0155	0.0156	0.0156	
6	0.015	0.496	0.100	0.399	959	0.751	0.75	0.75	1102	1100	1100	0.0156	0.0156	0.0156	
7	0.01	0.498	0.100	0.399	960	0.753	0.75	0.75	1104	1100	1100	0.0156	0.0156	0.0156	
8	0.008	0.498	0.100	0.399	960.7	0.754	0.75	0.75	1106	1100	1100	0.0156	0.0156	0.0156	
9	0.007	0.498	0.100	0.399	961.5	0.754	0.75	0.75	1106	1100	1100	0.0156	0.0156	0.0156	
10	0.006	0.499	0.100	0.399	962.2	0.755	0.75	0.75	1107	1100	1100	0.0156	0.0156	0.0156	

In this paper, we noted the prior distribution for d_i by PD_i . As mentioned earlier three distribution uniform, negative-exponential and half-normal are considered as a prior for d_i . The value of Weibull scale parameter λ_i

is calculated by the use of prior distributions. Other parameter formulas are as below:

$$W_i = \left(\frac{PD_i}{PD_5}\right) \times 1100\tag{49}$$

$$Z_{2i} = (\frac{PD_i}{PD_5}) \times 0.75 \tag{50}$$

$$\lambda_i = (\frac{PD_i}{PD_5}) \times \lambda_5 \tag{51}$$

Input parameters values are listed in Table 3.

Comparison between optimal values (n, h_1, L) and loss cost for our multiplicity-cause and single-cause model of Yang and Rahim (2006) is presented in Table 4 for different values of the shape parameter Weibull distribution. As seen in Table 4, a single-cause model has a higher loss cost than multiplicity-cause model except in the case of k = 1. In other words, when the process is affected by several assignable causes, and wrongly it is assumed that only single assignable cause affected the process, the loss cost will be increased. It should be noted that according to the values obtained in economic design, the upper limit of AATS was considered 1 and the upper limit of ANF were considered 0.5.

In Table 5 comparison between optimal values and loss cost for economic statistical design by considering the non-uniform sampling and uniform sampling scheme for different values of the Weibull distribution shape parameter is given. As it is seen in Table 5 when we use

Economic design										Economic Statistical design							
\overline{k}	PD	\overline{n}	h_1	L	α	$1 - \beta$	AATS	ANF	ECT	n	h_1	L	α	$1 - \beta$	AATS	$\frac{ANF}{}$	ECT
	\overline{YR}	12	1.2	5.47	0.065	0.9	0.747	0.262	1090.65	12	1.2	5.47	0.065	0.9	0.747	0.262	1090.65
1	NE	7	1.18	2.71	0.25	0.69	1.53	4.05	1127.09	97	1	7.24	0.026	0.85	0.99	0.5	1427.5
	Un	6	1.05	3.55	0.17	0.72	1.52	3.95	1106.9	100	1.21	7.39	0.025	0.99	1	0.5	1370.27
	HN	7	1.11	3.08	0.21	0.71	1.47	3.83	1120.29	100	1.16	7.07	0.029	0.89	0.99	0.49	1385.53
	YR	11	1.7	5.18	0.075	0.89	0.428	0.16	1171.17	11	1.7	5.18	0.075	0.89	0.428	0.16	1171.17
1.5	NE	6	2.27	2.2	0.33	0.72	0.6	1.71	1149	17	2.65	4.14	0.12	0.71	0.99	0.5	1177.4
	Un	6	2.05	3.33	0.19	0.72	0.547	1.52	1135.32	42	1.83	10.5	0.006	0.78	1	0.06	1336.54
	HN	7	2.14	2.71	0.26	0.72	0.56	1.55	1142.67	44	1.69	9.69	0.008	0.75	0.99	0.07	1367.21
	YR	11	1.76	5.07	0.079	0.88	0.36	0.13	1195.13	11	1.76	5.07	0.079	0.88	0.36	0.13	1195.13
1.8	NE	6	2.45	1.95	0.38	0.27	0.43	1.26	1151.94	40	1.73	10.3	0.005	0.66	1	0.038	1459.54
	Un	5	2.22	3.21	0.2	0.72	0.38	1.09	1140.68	10	2.88	3.74	0.15	0.77	0.55	0.5	1156.42
	HN	6	2.31	2.53	0.28	0.73	0.4	1.13	1144.94	13	2.91	3.23	0.2	0.77	0.57	0.5	1160.73
	YR	11	1.76	5	0.082	0.88	0.32	0.12	1204.79	11	1.76	5	0.082	0.88	0.32	0.12	1204.79
2	NE	4	2.49	1.79	0.41	0.75	0.36	1.07	1151.3	40	2	10.5	0.005	0.66	0.99	0.024	1449.842
	Un	5	2.25	3.13	0.21	0.72	0.32	0.93	1141.86	8	2.42	4.03	0.13	0.72	0.41	0.5	1148.92
	HN	6	2.34	2.42	0.3	0.73	0.338	0.96	1144.36	9	2.42	3.59	0.17	0.71	0.44	0.49	1152.69
	YR	10	1.73	4.89	0.087	0.87	0.264	0.1	1215.95	10	1.73	4.89	0.087	0.87	0.264	0.1	1215.95
2.5	NE	4	2.47	1.29	0.52	0.79	0.259	0.81	1146.18	6	2.83	1.33	0.51	0.72	0.33	0.51	1153
	Un	5	2.21	2.93	0.23	0.72	0.22	0.69	1140.55	6	2.47	2.89	0.23	0.75	0.26	0.49	1144.09
	HN	5	2.3	2.13	0.34	0.74	0.242	0.72	1139.48	7	2.4	2.58	0.27	0.74	0.28	0.49	1141.99
	YR	10	1.68	4.8	0.09	0.86	0.229	0.084	1217.35	10	1.68	4.8	0.09	0.86	0.229	0.084	1217.35
3	NE	4	2.35	1	0.6	0.81	0.203	0.63	1139	4	2.47	1	0.6	0.83	0.227	0.51	1140.36
	Un	4	2.12	2.74	0.25	0.72	0.17	0.54	1136.53	5	2.63	1.24	0.53	0.86	0.2	0.5	1148.57
	HN	5	2.21	1.83	0.4	0.76	0.19	0.57	1132.74	4	2.52	1.03	0.6	0.85	0.21	0.5	1136.46
	YR	10	1.57	4.67	0.097	0.86	0.18	0.68	1209.84	10	1.57	4.67	0.097	0.86	0.18	0.68	1209.84
4	NE	3	2.05	1	0.6	0.81	0.15	0.4	1125.9	3	2.05	1	0.6	0.81	0.15	0.4	1125.9
	Un	4	1.95	2.33	0.31	0.74	0.12	0.39	1126.8	4	1.95	2.33	0.31	0.74	0.12	0.39	1126.8
	HN	3	2.06	1	0.61	0.83	0.13	0.43	1118.74	3	2.06	1	0.61	0.83	0.13	0.43	1118.74

Table 4: Optimal parameters obtained under multiple assignable causes

economic statistical design, the loss cost becomes greater when uniform sampling scheme is used instead of non-uniform sampling scheme

7. Conclusions

In this paper, the economic design of T^2 control chart with multiple assignable causes under Weibull shock model with Taguchi loss function was presented. The cost model under multiple assignable causes compared with single cause model of Yang and Rahim (2006). The results showed that the model under multiple assignable causes with Taguchi loss function has a lower cost than single assignable cause model. In other words, when the process is affected by several assignable causes, and wrongly it is assumed that only single assignable cause affected the process, the loss cost will be increased.

Appendix A

Notations and definitions

 Z_0 : Average time to search for false alarm.

 Z_1 : Average time to discover assignable cause once it is detected by control chart.

 Z_{2i} : Average time to repair i^{th} assignable cause after it has been discovered.

 D_0 : Average cost per unit of time while the process in control.

 D_{1i} : Average cost per unit of time while the process is out of control owing to the occurrence of the i^{th} assignable cause (i = 1, 2, ..., s).

 L_{in} : Approximated in control cost obtained by considering modified Taguchi loss function.

 $L_{out,i}$: Approximated out of control cost obtained by considering modified Taguchi loss func-

Economic Statistical design with non-uniform sampling scheme Economic Statistical design with uniform sampling scheme PDL $1-\beta$ AATSANFECT $\overline{1}$ - β AATSANF h_1 \overline{YR} 5.47 0.065 0.9 0.747 0.262 1090.65 0.036 1094.34 12 1.2 13 1.4 6.62 0.88 0.9 0.5 1 NE97 1 7.24 0.026 0.850.990.51427.5 76 0.77.97 0.0190.8 1 0.51470.08Un100 1.21 7.39 0.025 0.99 1 0.51370.27 45 0.32 10.0 0.007 0.79 1 0.51600.9 HN100 1.16 7.07 0.029 0.89 0.990.491385.5372 0.797.85 0.019 0.83 1 0.51401.65YR11 1.7 5.18 0.0750.89 0.428 0.16 1171.1712 0.915.2 0.0740.99 0.550.5 1183.24 1.5 NE17 2.65 4.14 0.120.710.99 0.51177.451 0.97 5.02 0.08 0.721 0.51342 Un42 1.83 10.1 0.0060.781 0.06 1336.5448 1.15 5.04 0.08 0.88 1 0.51319.8HN44 1.69 9.69 0.008 0.75 0.990.07 1367.21 26 0.85 4.28 0.120.81 0.93 0.491327.63 YR11 1.76 5.070.079 0.880.360.131195.1310 0.784.79 0.0910.880.50.51219.731.8 NE40 1.73 10.30.0050.661 0.0381459.5447 1.18 3.820.140.851 0.51356.50.99 Un10 2.88 3.740.15 0.770.550.51156.4244 1.32 3.89 0.140.890.5 1363.43 HN2.91 13 3.23 0.2 0.570.5 1160.731.22 3.82 0.88 0.96 0.5 1353.81 0.7745 0.15YR1.76 5 0.082 0.32 0.12 1204.79 0.0940.421230.94 0.88 11 0.68 4.72 0.9 0.5 NE40 2 10.4 0.0241449.84 1.29 0.005 0.66 0.9947 3.22 0.20.870.98 0.5 1377 Un2.424.03 0.13 0.720.41 0.51148.9224 4.11 0.13 0.84 0.990.51333.48 2.42 1152.69 1327.63 HN3.59 0.84 0.93 9 0.170.710.440.4926 4.26 0.120.81 0.5 YR10 1.73 4.890.0870.87 0.2640.11215.9510 0.73.97 0.13 0.9 0.420.51270.02NE47 1429.82 6 2.83 1.33 0.51 0.720.33 0.51 1153 143 2.22 0.330.91 0.920.5 Un2.47 2.890.230.750.260.491144.0911 0.494.980.0820.720.910.51327.62HN2.4 2.58 0.27 0.740.28 0.491141.99 0.96 3.29 0.190.8 0.97 0.5 1353.43 17 YR10 1.68 4.80.090.860.2290.0841217.3510 0.793.250.20.940.440.51302.67NE2.47 1 0.227 0.51 1140.36 49 1.23 2.1 0.35 0.92 0.77 1449.74 0.6 0.830.5 Un2.63 1.24 0.530.860.20.51148.5712 0.62 4 0.13 0.780.79 0.51352.8 HN2.521.03 0.850.21 0.51136.4647 1.25 2.13 0.34 0.93 0.760.5 1463.84 0.6 YR10 1.57 4.67 0.097 0.860.18 0.68 1209.84 13 2.51 0.6 0.99 0.940.086 1507.75 NE3 2.051 0.6 0.81 0.15 0.4 1125.9511.01 2.01 0.37 0.920.620.51473.23 Un4 1.95 2.33 0.310.740.120.391126.8 47 1.05 2.10.350.940.610.51520.34

1118.74

1.02

2.04

0.36

0.84

0.6

0.5

1487.96

Table 5: Optimal parameters

tion.

Y: The average cost per false alarm when the process is under control.

0.13

0.43

 W_i : Cost to locate and repair i^{th} assignable cause.

0.61

0.83

a: Fixed sample cost.

2.06

b: Unit sample cost.

P: Production rate.

 Δ : Tolerance rate.

A: The cost to society for manufacturing a product out of specification.

 σ : Standard deviation of the process.

 λ_i : Weibull Scale parameter.

k: Weibull Shape parameter.

n: Sample size.

 h_1 : Sampling interval.

L: Control limits coefficient.

 ρ : Average correlation factor within samples.

Appendix B

According to Banerjee and Rahim (1988) and Regarding of h_i we have:

$$h_j = [j^{\frac{1}{k}} - (j-1)^{\frac{1}{k}}]h_1$$

We show h_j is decreasing based of j:

$$\frac{\partial}{\partial j} h_j = \left[\frac{1}{k} j^{\frac{1}{k} - 1} - \frac{1}{k} (j - 1)^{\frac{1}{k} - 1} \right] h_1$$
$$= \left[j^{\frac{1}{k} - 1} - (j - 1)^{\frac{1}{k} - 1} \right] \frac{h_1}{k}$$

 h_1 is sampling interval and positive. In the above formula, $\frac{1}{k}$ is positive, because the shape parameter of Weibull distribution $K \geq 1$. Hence $j^{\frac{1}{k}-1} - (j-1)^{\frac{1}{k}-1} \leq 0$, therefore we have: $\frac{\partial}{\partial j}h_j \leq 0$. Because of above reason, h_j is decreasing based of j.

Appendix C

Recall that the $X \sim N(\mu, V)$, with $V = \sigma^2 R$ is the process variance and R is the correlation matrix.

$$Var(\overline{X}) = \frac{1}{n^2} \left[\sum_{i=1}^n Var(X_i) + \sum_{i \neq j} Cov(X_i, X_j) \right]$$
$$= \frac{1}{n^2} \left[n\sigma^2 + \sum_{i \neq j} V_{ij} \right]$$
$$= \frac{1}{n^2} \left[n\sigma^2 + \sigma^2 \left\{ \sum_{i \neq j} r_{ij} \right\} \right]$$

Let $\rho = \frac{\sum_{i \neq j} r_{ij}}{n(n-1)}$. Then

$$Var(\overline{X}) = \frac{1}{n^2} [n\sigma^2 + \sigma^2 n(n-1)\rho]$$
$$= \frac{\sigma^2}{n} [1 + (n-1)\rho]$$

Appendix D

According to Banerjee and Rahim (1988) and Regarding equation (7), ω_j and h_j can be obtained as follows:

$$\int_{\omega_j}^{\omega_{j+1}} r_i(t) dt = \int_{\omega_0}^{h_1} r_i(t) dt, j = 1, 2, \dots$$

$$\int_{\omega_j}^{\omega_{j+1}} \lambda_i k t^{k-1}(t) dt = \int_{\omega_0}^{h_1} \lambda_i k t^{k-1}(t) dt$$
$$= \omega_{j+1}^k - \omega_j^k = h_1^k$$

If
$$j = 1 : \omega_2^k = \omega_1^k + h_1^k \Rightarrow \omega_2 = 2^{\frac{1}{k}} h_1$$

If
$$j = 2$$
: $\omega_3^k = \omega_2^k + h_1^k \Rightarrow \omega_3 = 3^{\frac{1}{k}} h_1$

:

Therefore $\omega_j = j^{\frac{1}{k}} h_1$ and

$$h_j = \omega_j - \omega_{j-1}$$

= $[j^{\frac{1}{k}} - (j-1)^{\frac{1}{k}}]h_1, j = 1, 2,$

Appendix E

Let $AATS_i$ be the average time between occurrence shifts in process mean owing to i^{th} assignable cause and receiving true alarm from control chart, Banerjee and Rahim (1988).

$$AATS_{i} = \sum_{j=1}^{\infty} \left[\sum_{k=1}^{\infty} q_{ij} [\omega_{k+j-1} - \omega_{j-1}] \beta_{i}^{k-1} (1 - \beta_{i}) \right] - \tau_{i}$$

$$= \sum_{j=1}^{\infty} \left[\sum_{k=1}^{\infty} (1 - p_{i})^{j-1} p_{i} [\omega_{k+j-1} - \omega_{j-1}] \beta_{i}^{k-1} (1 - \beta_{i}) \right] - \tau_{i}$$

$$= (1 - \beta_{i}) p_{i} \sum_{j=1}^{\infty} \left[\sum_{k=1}^{\infty} \left[(1 - p_{i})^{j-1} \omega_{k+j-1} \beta_{i}^{k-1} - (1 - p_{i})^{j-1} \omega_{j-1} \beta_{i}^{k-1} \right] \right] - \tau_{i}$$

For the first part, we have:

$$I = \sum_{j=1}^{\infty} \sum_{k=1}^{\infty} (1 - p_i)^{j-1} \omega_{k+j-1} \beta_i^{k-1}$$

$$= \sum_{l=1}^{\infty} \sum_{j=1}^{l} (1 - p_i)^{j-1} \omega_l \beta_i^{l-j}$$

$$= \sum_{l=1}^{\infty} \omega_l \beta_i^l \sum_{j=1}^{l} (1 - p_i)^{-1} (\frac{1 - p_i}{\beta_i})^j$$

$$= (\frac{1}{1 - p_i}) \sum_{l=1}^{\infty} \omega_l \beta_i^l (\frac{1 - p_i}{\beta_i - 1 + p_i}) - (\frac{1}{1 - p_i}) \sum_{l=1}^{\infty} \omega_l (\frac{(1 - p_i)^{l+1}}{\beta_i - 1 + p_i})$$

$$= (\frac{1}{p_i + \beta_i - 1}) (\sum_{l=1}^{\infty} \omega_l \beta_i^l - \sum_{l=1}^{\infty} \omega_l (1 - p_i)^l)$$

$$= (\frac{h_1}{p_i + \beta_i - 1}) (\beta_i A(\beta_i) - (1 - p_i) A(1 - p_i))$$

For the second part, we have:

$$II = \sum_{j=1}^{\infty} \sum_{k=1}^{\infty} (1 - p_i)^{j-1} \omega_{j-1} \beta_i^{k-1}$$

$$= \sum_{j=1}^{\infty} (1 - p_i)^{j-1} \omega_{j-1} \sum_{k=1}^{\infty} \beta_i^{k-1}$$

$$= \frac{h_1 (1 - p_i)}{1 - \beta_i} A (1 - p_i)$$

By substituting and simplifying, final formula is obtained.

Appendix F

If B_i is the event of the occurrence of i^{th} assignable cause, then

$$P(B_i) = P(T_i < Y),$$

where
$$Y = min(T_1, T_2, ..., T_{i-1}, T_{i+1}, ..., T_s)$$

Let $\lambda' = \sum_{i \neq j}$ and $\lambda_0 = \sum_{i \neq j} \lambda_j, j = 1, 2, ..., s$, then

$$P(B_i) = P(T_i < Y)$$

$$= \int_0^{+\infty} P(T_i < Y | Y = y) f_Y(y) dy$$

$$= \int_0^{+\infty} P(T_i < Y) f_Y(y) dy$$

$$= \int_0^{+\infty} (1 - e^{-\lambda_i y^k}) \lambda' k y^{k-1} e^{-\lambda y^k} dy$$

$$= \int_0^{+\infty} \lambda' k y^{k-1} e^{-\lambda y^k} dy$$

$$- \int_0^{+\infty} e^{-\lambda_i y^k} \lambda' k y^{k-1} e^{-\lambda y^k} dy$$

$$= 1 - \lambda' \int_0^{+\infty} k y^{k-1} e^{-y^k (\lambda_i + \lambda')} dy$$

$$= 1 - \frac{\lambda'}{\lambda_i + \lambda'}$$

$$= \frac{\lambda_i}{\lambda_0}$$

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